



# Variable selection for correlated data in high dimension using decorrelation methods

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# Variable selection for correlated data in high dimension using decorrelation methods

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*Joint work with*

*David Causeur*

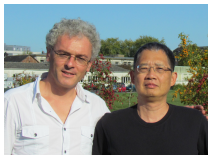
*Agrocampus, Rennes*

*Ching-Fan Sheu*

*NCKU, Tainan, Taiwan*

*Chloé Friguet*

*UBS, Vannes*



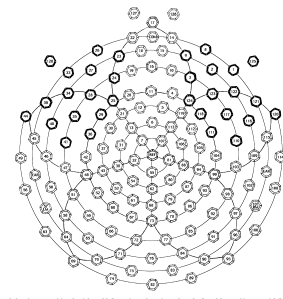
*StatLearn, Vannes, April 2016*

1. Introduction
2. Impact of dependence and dependence modeling
3. Disentangling signal from noise ...
  - ... for a multiple testing issue
  - ... for a supervised classification issue
4. Conclusion

# The instrument: a 128-channel geodesic sensor net

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- Electroencephalography (EEG) is the recording of electrical activity at scalp locations over time.
- The recorded EEG traces, which are time locked to external events, are averaged to form the event-related (brain) potentials (ERPs).



# Auditory oddball experiment

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## A very commonly used experimental task

- Two auditory stimuli are presented to subjects
  - A stimulus (500Hz) occurring frequently
  - A stimulus (1000Hz) occurring infrequently
- ERPs are recorded on a 400 ms interval after the onset.

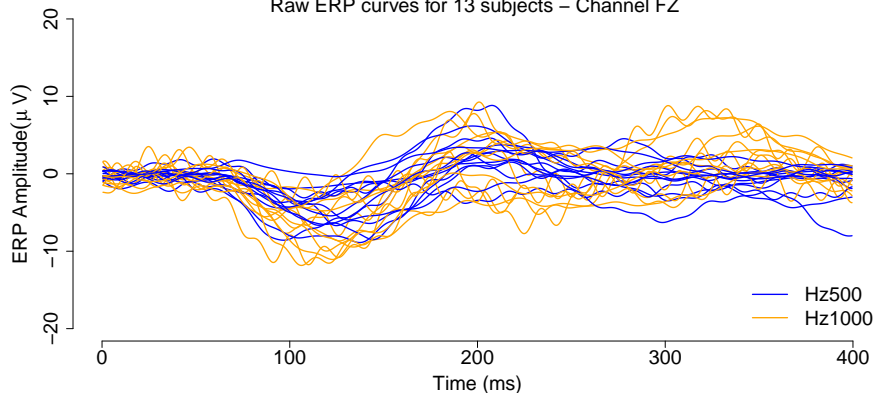
## Motivations

- Auditory evoked potential (AEP): elicited by auditory stimulus
- Mismatch negativity (MMN): elicited by any change in the stimulus (odd/frequent)
- AEP and MMN are electrophysiological marker candidates for psychiatric disorders such as schizophrenia

# ERP curves

## Auditory ERP data – Kaohsiung Medical University

Raw ERP curves for 13 subjects – Channel FZ



- Signal detection: is there any difference between the two conditions?
- Signal identification: when does the difference occur?

At time  $t$  for subject  $i$  in condition  $j$

- Multivariate analysis of variance model

$$Y_{ijt} = \mu_t + \alpha_{it} + \gamma_{jt} + \varepsilon_{ijt}$$

- Functional analysis of variance model

$$Y_{ijt} = \sum_{s=1}^S m_s \varphi_s(t) + \sum_{s=1}^S a_{is} \varphi_s(t) + \sum_{s=1}^S g_{js} \varphi_s(t) + \varepsilon_{ijt}$$

where  $\varphi_s(\cdot)$ ,  $s = 1, \dots, S$  are B-splines.

# Linear model framework for ERP curves

---

At time  $t$  for subject  $i$  in condition  $j$

$$Y_{ijt} = \mu_t + \alpha_{it} + \gamma_{jt} + \varepsilon_{ijt}$$

## Signal detection

- Is there any difference between the two conditions?

$$H_0 : \text{for } t = 1, \dots, T \text{ and } j = 1, 2, \gamma_{jt} = 0$$

- Is it relevant to predict the label from ERP curves?

→ High dimension: need for variable selection

## Signal identification

$$\text{For } t = 1, \dots, T, H_{0t} : \text{for } j = 1, 2, \gamma_{jt} = 0$$



# Some approaches

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## Detection

- F-test for multivariate (or functional) ANOVA <sup>1</sup>
- Optimal detection (Higher Criticism <sup>2</sup>)

## Supervised classification

- Ignoring correlations: Naive approaches <sup>3</sup>
- Introducing sparsity: Lasso, Sparse LDA <sup>4</sup>

## Identification

- FDR controlling: Benjamini-Hochberg ...

→ Efficient under independence

- 
1. Bugli and Lambert, 2006, Stat Med
  2. Donoho and Jin, 2004, AOS
  3. Bickel and Levina, 2004, Bernoulli ; Tibshirani et al., 2003, Stat Sc
  4. Tibshirani, 1996, JRSS ; Clemmensen et al., 2011, Technometrics

- Assumes an auto-regressive process with auto-correlation  $\rho$
- Distribution of  $L_\rho$  under the null

$$L_\rho = \#\{t, p_t \leq \alpha\}$$

where  $(p_1, \dots, p_T)$  are p-values and  $\alpha$  is a preset level

- A time interval is rejected if it is significant at the preset level and longer than usual time intervals

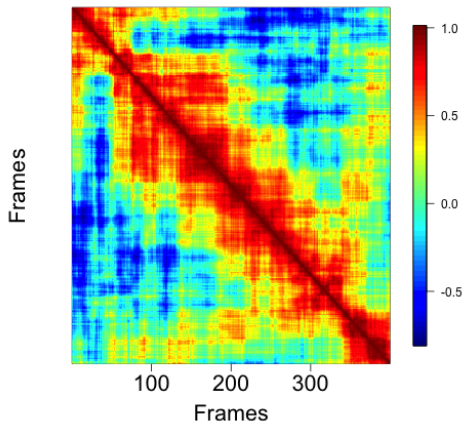
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5. Guthrie and Buchwald, 1991, Psychophysiology

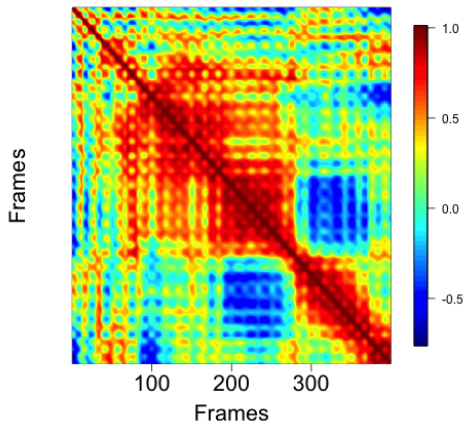
# Strong and complex temporal dependence structure

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**Time correlations of an AR(1) process**



**Time correlations of ERP data**



→ Dependence affects the stability of selection procedures

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- Two components mixture for test statistics

$$\mathcal{T} = \mu + \varepsilon, \varepsilon \sim \mathcal{N}(0, \mathbb{I}_T)$$

- Where signal is

- Rare

$$\eta = T^{-\beta}, \beta \in (\frac{1}{2}, 1)$$

- Weak

$$A = \sqrt{2r \log(T)}, r \in (0, 1)$$

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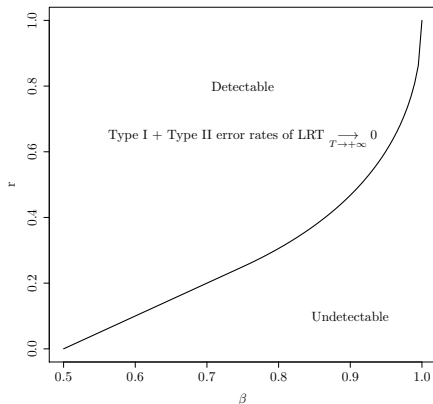
6. Donoho and Jin, 2004, AOS ; 2008, PNAS

## Phase diagram under independence<sup>7</sup>

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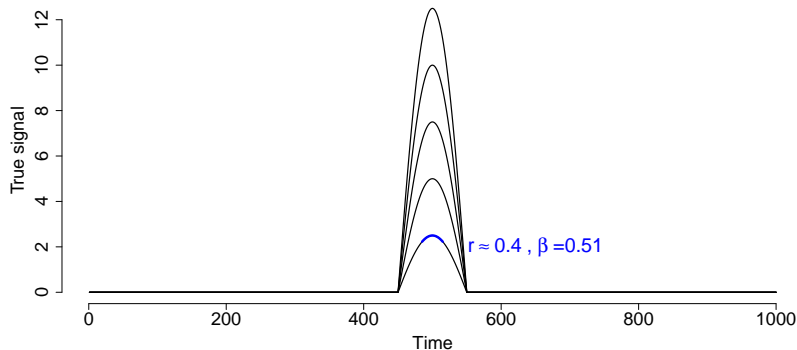
- Signal is detectable when  $r > \rho^*(\beta)$  :

$$\rho_D^*(\beta) = \begin{cases} \beta - \frac{1}{2} & \text{if } \frac{1}{2} < \beta \leq \frac{3}{4} \\ (1 - \sqrt{1 - \beta})^2 & \text{if } \frac{3}{4} < \beta < 1. \end{cases}$$



# Impact of dependence - Signal identification

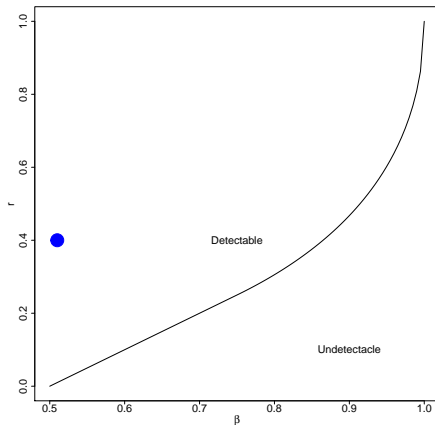
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- Independence and ERP time dependence pattern
- 1000 datasets for each amplitude
- Benjamini Hochberg correction

# Impact of dependence - Signal identification

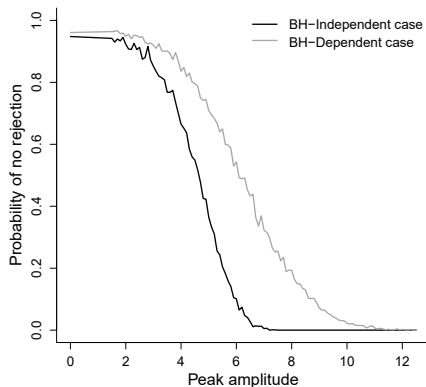
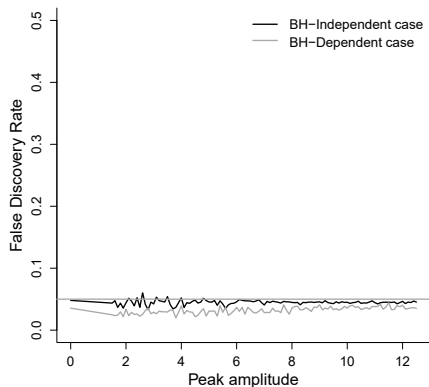
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- Independence and ERP time dependence pattern
- 1000 datasets for each amplitude
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# Impact of dependence - Signal identification

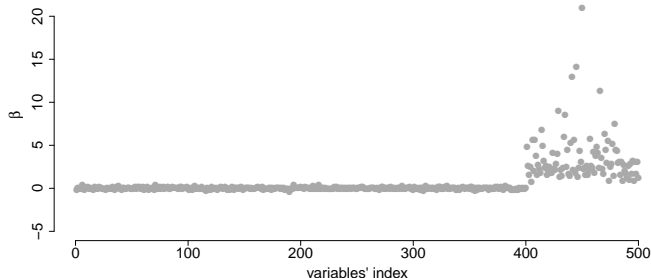


- Instability of multiple testing procedures

$$\text{FDR} = \text{pFDR}(1-\text{PNR})$$

# Impact of dependence - Variable selection

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$$\log \frac{\mathbb{P}(Y = 2|X)}{\mathbb{P}(Y = 1|X)} = \beta_0 + \beta'x$$

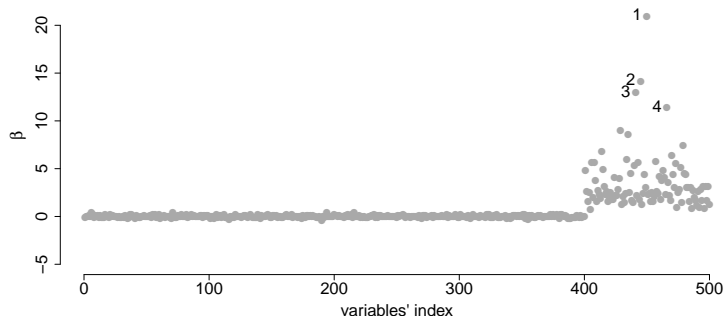
- Independence and ERP time dependence pattern
- 1000 datasets for each dependence structure
- Variable selection performed by Lasso<sup>8</sup>

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8. `glmnet` R package, Friedman et al., 2010, JSS

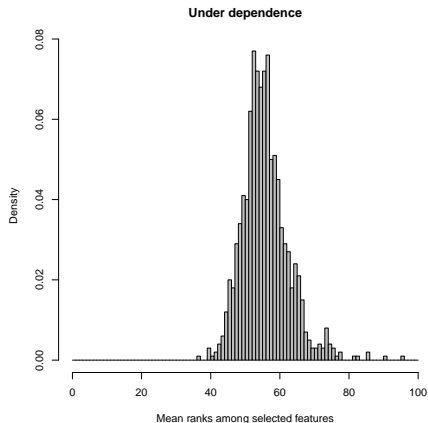
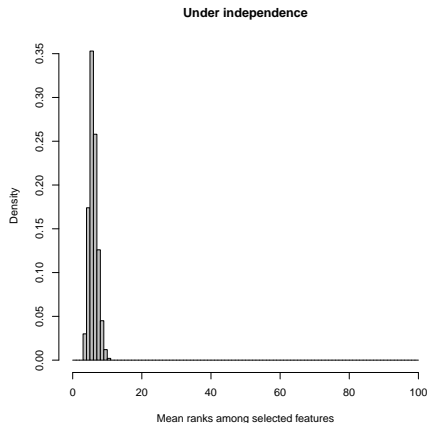
# Impact of dependence - Variable selection

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- Predictor  $X_t$  is assessed by its rank  $r_t$  deduced from its regression coefficient
- Relevance of a selected set  $\mathcal{S}$  is given by the mean rank in  $\mathcal{S}$ : 
$$r_{\mathcal{S}} = \frac{1}{\#\mathcal{S}} \sum_{t \in \mathcal{S}} r_t$$

# Impact of dependence - Variable selection



- Relevance: the most predictive variables are not selected under dependence
- Stability: selected subsets are not reproducible

- Bootstrap
  - Bolasso<sup>9</sup>
  - Stability selection<sup>10</sup>
- Dependence modeling
  - Surrogate variable analysis<sup>11</sup>
  - Latent effect adjustment after primary projection<sup>12</sup>
  - Factor analysis for multiple testing<sup>13</sup>

---

9. Bach, 2008, Proceedings ICML

10. Meinshausen and Bühlmann, 2010, JRSS

11. Leek and Storey, 2007, PLoS Genetics

12. Sun, Zhang and Owen, 2012, AOAS

13. Friguet, Kloareg and Causeur, 2009, JASA

# Factor modeling of dependence

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- Distribution of ERP curves

$$X = (X_1, \dots, X_T) | Y = y \sim \mathcal{N}_T(\mu_y, \Sigma)$$

- Latent factor modeling

$$X = \mu_y + BZ + e \text{ with } e \sim \mathcal{N}_T(0, \Psi)$$

$$\Psi \text{ diagonal, } \text{rank}(B) = q,$$

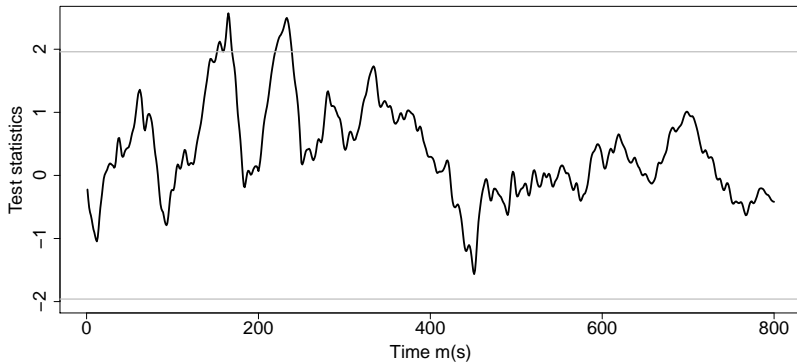
$$Z \sim \mathcal{N}_q(0, \mathbb{I}_q),$$

- Decomposition of covariance matrix

$$\Sigma = \Psi + BB'$$

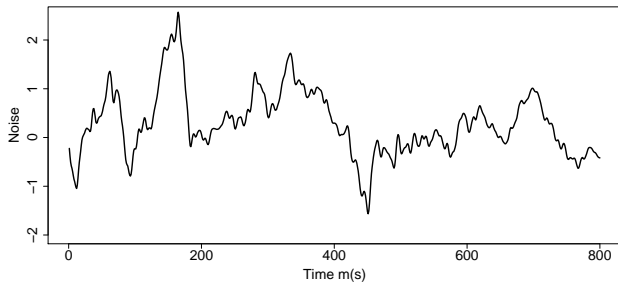
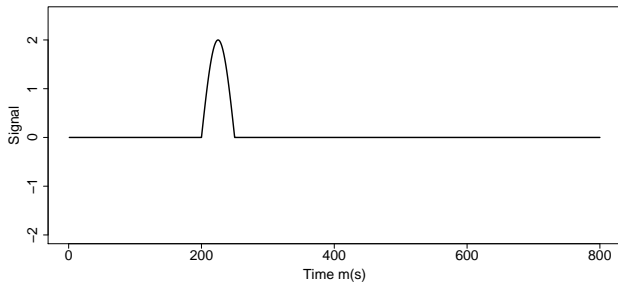
## Signal is hidden by noise

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# Signal is hidden by noise

---





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# Multiple testing issue

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- ERP measure at time  $t$ , for subject  $i$ ,

$$Y_{ijt} = \mu_t + \alpha_{it} + \gamma_{jt} + \varepsilon_{ijt}$$

- In matrix notations

$$Y_t = \mu_t + X_0 \alpha_t + X \gamma_t + \varepsilon_t$$

with  $\mathbb{V}(\varepsilon_1, \dots, \varepsilon_T) = \Sigma$

- Multiple testing for  $t = 1, \dots, T$

$$H_{0,t} : \gamma_t = 0$$

- Dependence among tests

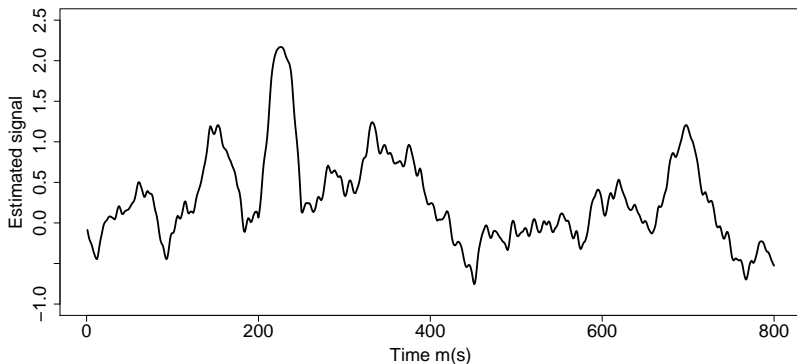
## A prior knowledge of the signal

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- OLS signal estimation of  $\gamma = (\gamma_1, \dots, \gamma_T)$

$$\hat{\gamma} = \gamma + \delta$$

with  $\delta \sim \mathcal{N}(0, \tilde{\Sigma})$  and  $\tilde{\Sigma} \propto \Sigma$



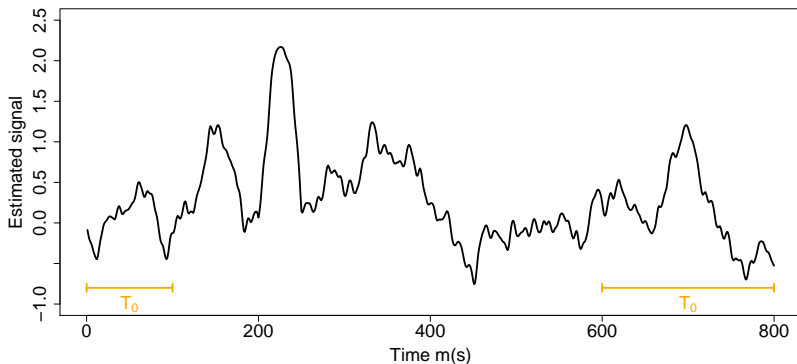
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$$\hat{\gamma} = \gamma + \delta$$

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## A prior knowledge of the signal

---

- OLS signal estimation of  $\gamma = (\gamma_1, \dots, \gamma_T)$

$$\hat{\gamma} = \gamma + \delta$$

with  $\delta \sim \mathcal{N}(0, \tilde{\Sigma})$  and  $\tilde{\Sigma} \propto \Sigma$

- Noise is somewhere observed **without** signal

$$\begin{pmatrix} \delta_0 \\ \delta_{-0} \end{pmatrix} \sim \mathcal{N} \left[ \begin{pmatrix} 0 \\ 0 \end{pmatrix}, \begin{pmatrix} \tilde{\Sigma}_{0,0} & \tilde{\Sigma}'_{-0,0} \\ \tilde{\Sigma}_{-0,0} & \tilde{\Sigma}_{-0,-0} \end{pmatrix} \right]$$

- And can be estimated elsewhere

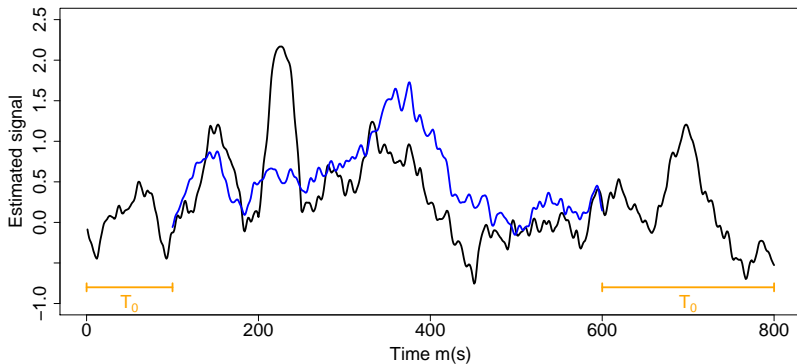
$$\hat{\delta}_{-0} = \hat{\Sigma}_{-0,0} \hat{\Sigma}_{0,0}^{-1} \hat{\delta}_0$$

# A prior knowledge of the signal

---

- And can be estimated elsewhere

$$\hat{\delta}_{-0} = \hat{\Sigma}_{-0,0} \hat{\Sigma}_{0,0}^{-1} \hat{\delta}_0$$

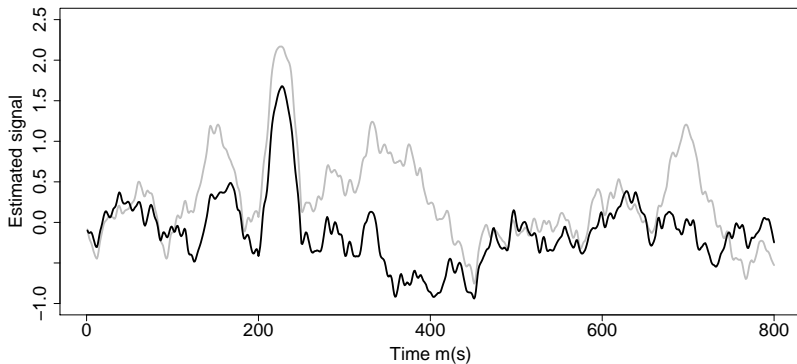


# A prior knowledge of the signal

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- New estimation of the signal

$$\hat{\gamma}^{\text{new}} = \hat{\gamma} - \hat{\delta}$$



# Iterative algorithm

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- New estimation of the signal

$$\hat{\gamma}^{\text{new}} = \hat{\gamma} - \hat{\delta}$$

- Update of residual errors  $\hat{\varepsilon}^{\text{new}} = Y_t - (\hat{\mu}_t + \hat{\alpha}_{it} + \hat{\gamma}_t^{\text{new}})$
- New estimation of covariance matrix
- Alternates estimation of signal and covariance structure
- Until convergence of test statistics
- Update of  $T_0$



## Prior knowledge

- ERP: psychologists may know that signal does not occur before/after some time points
- Genomics: biologists may know that some genes are not involved in a biological process

## No prior knowledge

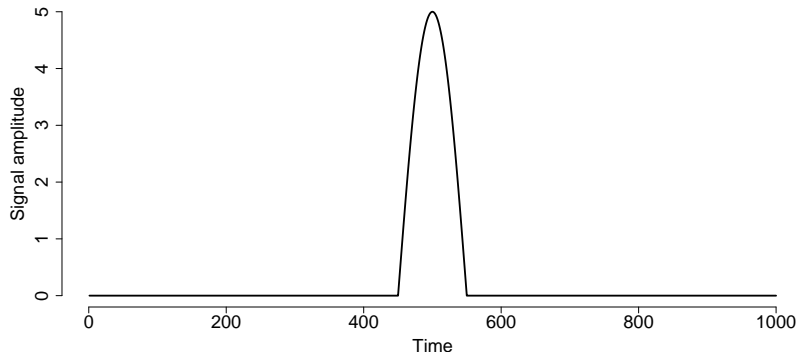
- Conservative approach

$$T_0 = \{t, p_t \geq t_0\}$$

where  $(p_1, \dots, p_T)$  are p-values

## Simulations - Adaptive factor analysis procedure

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- Dependence structure of ERP experiment
- 1000 generated datasets

## Simulations - Adaptive factor analysis procedure

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Method	FDR <sup>14</sup>	TDR <sup>15</sup>	PD <sup>16</sup>
Benjamini-Hochberg	0.031	0.057	0.281
Benjamini-Yekutieli	0.009	0.011	0.101
Guthrie-Buchwald	0.086	0.233	0.538
SVA	0.088	0.151	0.599
LEAPP	0.151	0.304	0.847
AFA	0.034	0.498	1.000

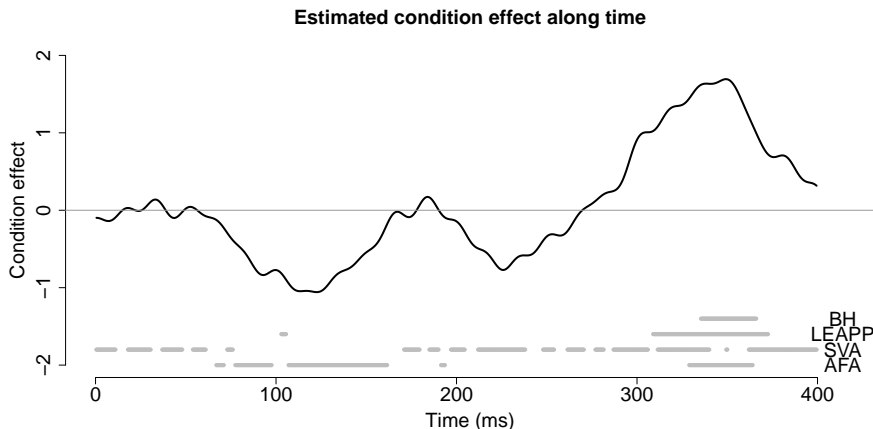
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14. False Discovery Rate

15. True Discovery Rate

16. Probability of Detecting the peak

# Application to auditory data



80 - 120 ms: Auditory evoked potential

100 - 200 ms: Mismatch negativity for the difference curve

- Adaptive estimation of signal and factor model parameters
- Designed for strong dependence
- Efficient multiple testing procedure
  - FDR is controlled
  - Good detection power
- ERP package available on CRAN<sup>17</sup>

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17. Causeur and Sheu, 2014, R package version 1.0.1

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## Supervised classification issue

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- Prediction of a label  $\rightarrow$  Hz500 or Hz1000 frequency
- From ERP curves profiles  $X = (X_1, \dots, X_T)$

$$(X|Y = y) \sim \mathcal{N}_p(\mu_y, \Sigma)$$

- Among linear classification rule

$$LR(x) = \log \frac{\mathbb{P}(Y = 2|X)}{\mathbb{P}(Y = 1|X)} = \beta_0 + x'\beta$$

- The best one is Bayes' rule

$$\begin{aligned}\beta &= \Sigma^{-1}(\mu_2 - \mu_1) \\ \beta_0 &= \log \frac{p_2}{p_1} - 0.5(\mu_2 + \mu_1)'\Sigma^{-1}(\mu_2 - \mu_1)\end{aligned}$$

- Theoretical misclassification rate  $\pi$

## Logistic regression

- Minimizing the deviance

$$(\hat{\beta}_0, \hat{\beta}) = \operatorname{argmin}_{\beta_0, \beta} -2 \sum_{i=1}^n \log[1 + \exp(-V_i(\beta_0 + x_i' \beta))]$$

where  $V_i = \pm 1$

- High dimension
  - $\ell_2$ -penalization: Ridge<sup>18</sup>
  - $\ell_1$ -penalization: Lasso<sup>19</sup>

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18. Hoerl and Kennard, 1970, Technometrics

19. Tibshirani, 1996, JRSS



## Linear Discriminant Analysis

- OLS estimate  $\rightarrow$  Method of moments

$$(\hat{\beta}_0, \hat{\beta}) = \operatorname{argmin}_{\beta_0, \beta} \sum_{i=1}^n [V_i - (\beta_0 + x_i' \beta)]^2, \text{ where } V_i = \pm 1$$

- High dimension
  - Ignoring correlations: Diagonal Discriminant Analysis (DDA)<sup>18</sup>, Nearest Shrunken Centroids<sup>19</sup>
  - Shrinkage Discriminant Analysis<sup>20</sup> (SDA)
  - Sparse linear discriminant analysis<sup>21</sup> (SLDA)

---

18. Bickel and Levina, 2004, Bernoulli

19. Tibshirani et al., 2003, Stat Sc

20. Ahdesmäki and Strimmer, 2010, AOAS

21. Clemmensen et al., 2011, Technometrics

## Conditional classification rule

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- Under factor model assumption ( $\Sigma = \Psi + BB'$ )

$$\begin{pmatrix} X \\ Z \end{pmatrix} \sim \mathcal{N} \left[ \begin{pmatrix} \mu_y \\ 0 \end{pmatrix}, \begin{pmatrix} \Sigma & B \\ B' & I_q \end{pmatrix} \right]$$

- Among classification rules linear in  $(x, z)$
- The best one is the **conditional Bayes' classifier**

$$LR(x, z) = \log \frac{\mathbb{P}(Y = 2|X, Z)}{\mathbb{P}(Y = 1|X, Z)} = \beta_0^* + (x - Bz)' \beta^*$$

$$\text{with } \beta^* = \Psi^{-1}(\mu_2 - \mu_1)$$

$$\beta_0^* = \log \frac{p_2}{p_1} - 0.5(\mu_2 + \mu_1)' \Psi^{-1}(\mu_2 - \mu_1)$$

- Analytical expression of misclassification rate  $\pi_Z^*$

## Conditional classification rule

---

- Bayes rule error  $\pi$
- Under factor model assumption

$$\begin{pmatrix} X \\ Z \end{pmatrix} \sim \mathcal{N} \left[ \begin{pmatrix} \mu_y \\ 0 \end{pmatrix}, \begin{pmatrix} \Sigma & B \\ B' & I_q \end{pmatrix} \right]$$

- Conditional Bayes rule error  $\pi_Z^*$
- One can show that  $\pi \geq \pi_Z^*$

→ Theoretical superiority of conditional approach based on decorrelated data  $\tilde{X} = X - BZ$

- Estimation of  $\mu_1$  and  $\mu_2$
- Computation of centered profiles
- Estimation of factor model parameters<sup>22</sup>  $(\Psi, B)$
- Decorrelation of data using generalized Thompson's formula

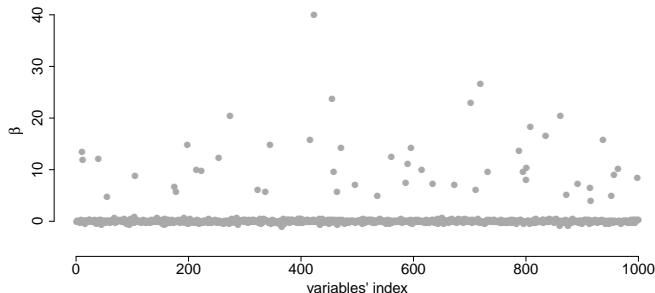
$$\tilde{x} = x - \hat{B}\hat{z}'$$

## Generalized Thompson's formula

$$\hat{Z} = \mathbb{E}_X(Z) = (I_q + B'\Psi^{-1}B)^{-1}B'\Psi^{-1}\left(x - [\mu_1\mathbb{P}_X(1) + \mu_2\mathbb{P}_X(2)]\right)$$

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22. Friguet, Kloareg and Causeur, 2009, JASA



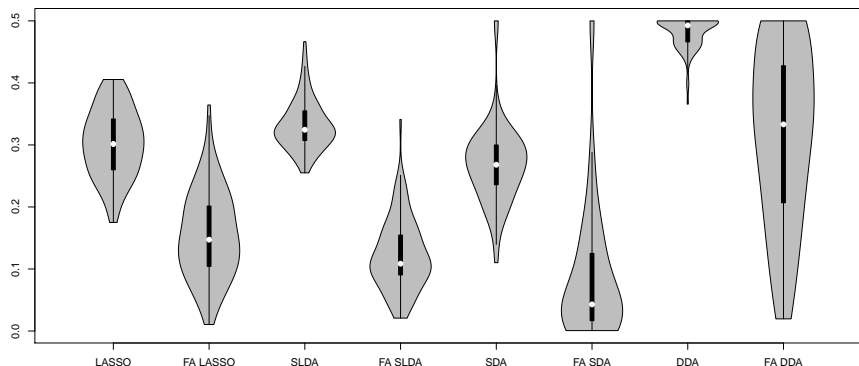
- $n_0 = n_1 = 13$
- Various dependence structures<sup>23</sup>
- 1000 learning datasets
- 1 testing dataset

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23. Meinshausen and Bühlmann, JRSS, 2010

## Simulations - Prediction error rates

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→ Variable selection methods compared to their factor-adjusted version

## Simulations - Selection accuracy

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Method	Nb of selected var.	Accuracy
LASSO <sup>24</sup>	13.10	62.36
Factor-adjusted LASSO	8.03	93.02
SLDA <sup>25</sup>	10.00	62.50
FA SLDA	10.00	90.90
SDA <sup>26</sup>	57.20	75.07
FA SDA	68.22	67.93
DDA <sup>27</sup>	149.42	15.58
FA DDA	97.65	48.76

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24. Tibshirani, 1996, JRSS ; Friedman et al., 2010, JSS

25. Clemmensen et al., 2011, Technometrics

26. Ahdesmäki and Strimmer, 2010, AOAS

27. Bickel and Levina, 2004, Bernoulli

- Decorrelation method designed for prediction issues
- Preprocessing of the data which enables the use of usual selection methods
- FADA package available on CRAN<sup>28</sup>
- Application in genomics
- Adjustment for batch effect<sup>29</sup>

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28. Perthame, Friguet and Causeur, 2014, R package version 1.2

29. Hornung, Boulesteix and Causeur, submitted



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→ Whatever the statistical analysis, it would be efficient to account for dependence because it is a *blessed* situation<sup>30</sup>

→ Accounting for dependence introduces hyper-parameters

- Risk of overfitting
- Results depend on the estimation of the dependence model
  - Need for robust models
  - With few parameters
  - To guarantee reproducible results

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30. Hall and Jin, 2010, AOS

D. Causeur and C.-F. Sheu.

*ERP: Significance analysis of Event-Related Potentials data*, 2014.

R package version 1.0.1.

E. Perthame, C. Friguet, and D. Causeur.

*FADA: Variable selection for supervised classification in high dimension*, 2014.

R package version 1.2.

E. Perthame, C. Friguet, and D. Causeur.

Stability of feature selection in classification issues for high-dimensional correlated data.

*Statistics and Computing*, pages 1–14, 2015.

C. Sheu, E. Perthame, D. Causeur, and Y. Lee.

Accounting for time dependence in large-scale multiple testing of event-related potential data.

*AOAS*, 10(1):219–245, 2016.